

<b>Notice of References Cited</b>	Application/Control No. 10/800,126	Applicant(s)/Patent Under Reexamination LEE, CHAN BOK	
	Examiner Mark A. Williams	Art Unit 3676	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,688,797	02-2004	Park et al.	403/93
	B	US-2,557,716	06-1951	ALLEE HERBERT D	16/250
	C	US-5,842,508	12-1998	Krupke et al.	160/235
	D	US-4,893,666	01-1990	Hormann, Michael	160/229.1
	E	US-5,669,431	09-1997	Druzynski et al.	160/229.1
	F	US-4,040,142	08-1977	Ippolito, Marceau	16/251
	G	US-5,220,708	06-1993	Lucas et al.	16/225
	H	US-1,626,844	05-1927	KUHN CLINTON J	160/229.1
	I	US-6,298,605	10-2001	Delefosse et al.	49/383
	J	US-6,029,409	02-2000	Wilson, Roger D.	52/202
	K	US-3,941,180	03-1976	Thill, Timothy N.	160/229.1
	L	US-3,319,697	05-1967	KROHN JOHN M	160/229.1
	M	US-6,343,406	02-2002	Yeh, Tom	16/328

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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